## SN74LVC158A QUADRUPLE 2-LINE TO 1-LINE DATA SELECTOR/MULTIPLEXER

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- **EPIC™** (Enhanced-Performance Implanted CMOS) Submicron Process
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  < 0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
  2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Inputs Accept Voltages to 5.5 V
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages

#### D, DB, OR PW PACKAGE (TOP VIEW) 16 VCC A/B 15 🛚 🗔 1A [ 1В Г 14 1 4A 1Y Π 13**∏** 4B 2A 12 1 4Y 2B [ 11 🛮 3A 2Y 🛮 7 10 3B 9**∏** 3Y GND

## description

This quadruple 2-line to 1-line data selector/multiplexer is designed for 2.7-V to 3.6-V  $V_{CC}$  operation.

The SN74LVC158A features a direct strobe ( $\overline{G}$ ) input. When the strobe is high, all outputs are high. When the strobe is low, a 4-bit word is selected from one of two sources and is routed to the four outputs. The SN74LVC158A provides inverted data.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices in a mixed 3.3-V/5-V system environment.

The SN74LVC158A is characterized for operation from -40°C to 85°C.

### **FUNCTION TABLE**

	INPUTS			OUTPUT
G	Ā/B	Α	В	Y
Н	Х	Χ	Χ	Н
L	L	L	X	Н
L	L	Н	X	L
L	Н	Χ	L	Н
L	Н	Χ	Н	L

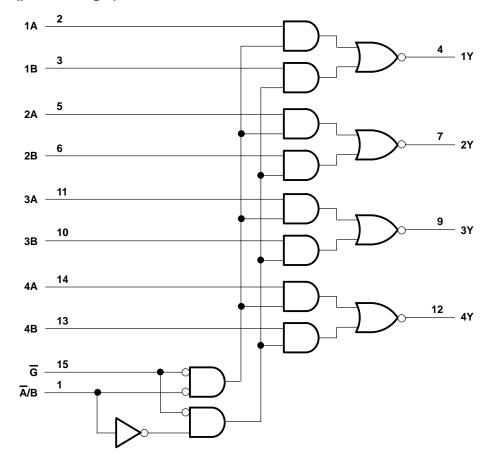


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# logic diagram (positive logic)



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	
Input voltage range, V <sub>I</sub> (see Note 1)	0.5 V to 6.5 V
Output voltage range, VO (see Notes 1 and 2)	0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, $I_{ K }(V_{ C } < 0)$	
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> )	±50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V <sub>CC</sub> or GND	±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3): D package	113°C/W
DB package	
PW package	
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
  - 2. The value of V<sub>CC</sub> is provided in the recommended operating conditions table.
  - 3. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

## recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
VCC	Supply voltage	Operating	2	3.6	V
		Data retention only	1.5		V
$V_{IH}$	High-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		V
٧ <sub>IL</sub>	Low-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8	V
٧ı	Input voltage		0	5.5	V
٧o	Output voltage		0	VCC	V
la	High-level output current	V <sub>CC</sub> = 2.7 V		-12	mA
ЮН		V <sub>CC</sub> = 3 V		-24	IIIA
1	Low-level output current	V <sub>CC</sub> = 2.7 V		12	mΑ
IOL	Low-level output current	V <sub>CC</sub> = 3 V		24	IIIA
Δt/Δν	Input transition rise or fall rate		0	10	ns/V
TA	Operating free-air temperature		-40	85	°C

NOTE 4: Unused inputs must be held high or low to prevent them from floating.

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST Co	ONDITIONS	VCC	MIN	TYP <sup>†</sup>	MAX	UNIT	
Voн	$I_{OH} = -100 \mu\text{A}$		2.7 V to 3.6 V	V <sub>CC</sub> -0.2			٧	
	I <sub>OH</sub> = -12 mA		2.7 V	2.2				
			3 V	2.4				
	I <sub>OH</sub> = -24 mA		3 V	2.2			1	
	I <sub>OL</sub> = 100 μA		2.7 V to 3.6 V			0.2		
V <sub>OL</sub>	I <sub>OL</sub> = 12 mA		2.7 V			0.4	V	
	I <sub>OL</sub> = 24 mA		3 V			0.55		
lį	V <sub>I</sub> = 5.5 V or GND		3.6 V			±5	μΑ	
loz	$V_O = V_{CC}$ or GND		3.6 V			±10	μΑ	
Icc	$V_I = V_{CC}$ or GND,	IO = 0	3.6 V			10	μΑ	
ΔlCC	One input at V <sub>CC</sub> – 0.6 V,	Other inputs at V <sub>CC</sub> or GND	2.7 V to 3.6 V			500	μΑ	
Ci	$V_I = V_{CC}$ or GND		3.3 V				pF	
Co	$V_O = V_{CC}$ or GND		3.3 V				pF	

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C.

# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 3.3 V ± 0.3 V	V <sub>CC</sub> = 2.7 V	UNIT
			MIN MAX	MIN MAX	
<sup>t</sup> pd	A or B	Y			
	Ā/B				ns
	G				
t <sub>sk(o)</sub> ‡					ns

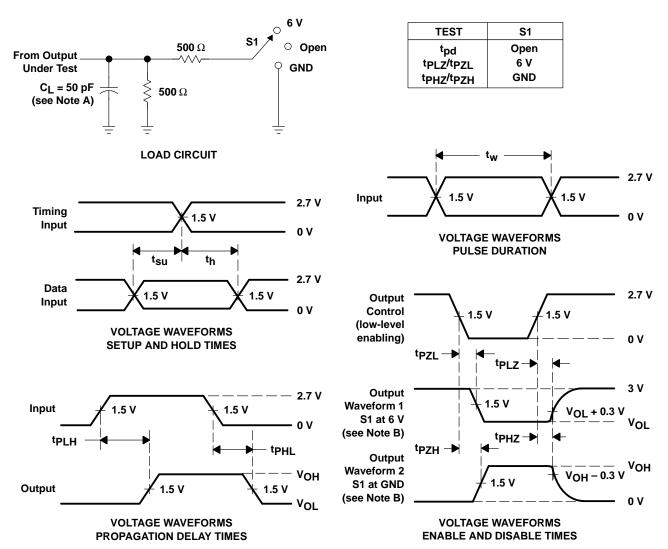
<sup>‡</sup> Skew between any two outputs of the same package switching in the same direction. This parameter is warranted but not production tested.

# operating characteristics, $V_{CC} = 3.3 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

PARAMETER		TEST C	ONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	$C_{L} = 0$ ,	f = 10 MHz	·	pF



### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq 2.5 \text{ ns. } t_f \leq 2.5 \text{ ns.}$
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpZL and tpZH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms

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